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Fifth Semester B.E. Degree Examination, June/July 2015
Fundamentals of CMOS VLSI

Time: 3 hrs.

Max. Marks: 100.

**Note: Answer any FIVE full questions, selecting
atleast TWO questions from each part.**

PART – A

1.
 - a. Discuss the nMOS enhancement mode transistor for different conditions of vds. (06 Marks)
 - b. Elaborate the concept of P-well falorication with neat sketches. (10 Marks)
 - c. Compare CMOS and bipolar technologies. (04 Marks)
2.
 - a. Obtain the transfer characteristics of a CMOS inverter and mark all the regions. Showing the status of PMOS and NMOS transistors. (10 Marks)
 - b. Illustrate the schematic and stick diagram for the expression $Y = \overline{A(B+C)}$. (10 Marks)
3.
 - a. Discuss in detail the λ - based design for CMOS. (10 Marks)
 - b. Realize a 3-input NAND gate for clocked CMOS logic and also for CMOS domino logic. (06 Marks)
 - c. Discuss the working of pseudo nMOS logic with suitable example. (04 Marks)
4.
 - a. Describe the delay unit τ in terms of sheet resistance and area capacitance for the CMOS inverter pain shown, calculate the total delay. (08 Marks)

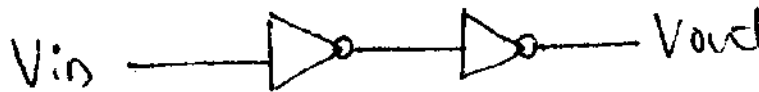


Fig. Q4(a)

- b. Explain in brief the wiring capacitances. (06 Marks)
- c. Narrate the steps involved in calculate the sheet resistance of :
 - i) Transistor channel
 - ii) nMOS inverter
 - iii) CMOS inverter. (06 Marks)

PART – B

5.
 - a. What are the scaling factors for the following device parameters :
 - i) Gate capacitance c_g
 - ii) max-operating frequency f_0
 - iii) current density
 - iv) power dissipation per gate p_g
 - v) power speed product PT. (10 Marks)
 - b. Design a parity generator with the following specifications and draw the stick diagram of one basic cell. (10 Marks)

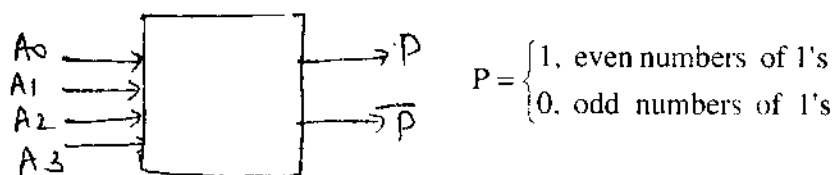


Fig. Q5(b)

- 6 a. Draw the basic form of a two-phase clock generator and explain in detail. (08 Marks)
b. Discuss the architectural issues to be followed in the design of a VLSI subsystem. (06 Marks)
c. Explain the precharge bus approach used in system design. (06 Marks)
- 7 a. Explain the three transistor dynamic RAM cell. (10 Marks)
b. Discuss the Bangh-Wooley method used for two's complement multiplication. (10 Marks)
- 8 a. Narrate the meaning of "Real Estate" in VLSI design. (05 Marks)
b. Explain testing and testability in detail. (10 Marks)
c. Write a short note on scan design techniques. (05 Marks)

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